

FUJI POWER MOSFET Super FAP-G Series

N-CHANNEL SILICON POWER MOSFET

■ Features

- High speed switching
- Low on-resistance
- No secondary breakdown
- Low driving power
- Avalanche-proof

■ Applications

- Switching regulators
- UPS (Uninterruptible Power Supply)
- DC-DC converters

■ Maximum ratings and characteristic Absolute maximum ratings

● (Tc=25°C unless otherwise specified)

Item	Symbol	Ratings	Unit
Drain-source voltage	V _{DS}	150	V
	V _{DSX} *5	130	V
Continuous drain current	I _D	±33	A
Pulsed drain current	I _{D(puls)}	±132	A
Gate-source voltage	V _{GS}	±20	V
Repetitive or non-repetitive	IAR *2	33	A
Maximum Avalanche Energy	EAS *1	169	mJ
Maximum Drain-Source dV/dt	dV _{DS} /dt *4	20	kV/μs
Peak Diode Recovery dV/dt	dV/dt *3	5	kV/μs
Max. power dissipation	P _D	T _a =25°C	2.16
		T _c =25°C	53
Operating and storage temperature range	T _{ch}	+150	°C
	T _{stg}	-55 to +150	°C

*1 L=0.228mH, V_{CC}=48V, T_{ch}=25°C, See to A valanche Energy Graph *2 T_{ch}≤150°C

*3 I_F≤-I_D, -di/dt=50A/μs, V_{CC}≤BV_{DSS}, T_{ch}≤150°C *4 V_{DS}≤150V *5 V_{GS}=-20V

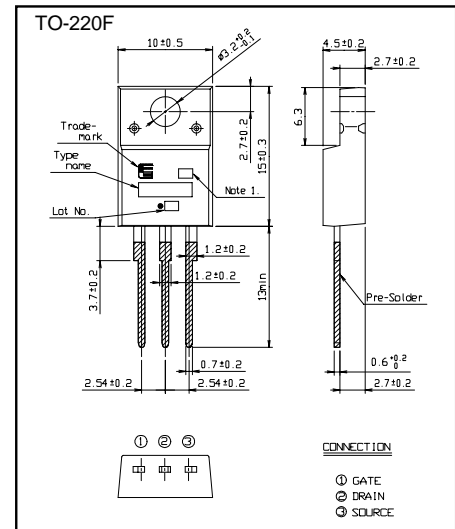
● Electrical characteristics (T_c =25°C unless otherwise specified)

Item	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain-source breakdown voltage	V _{(BR)DSS}	I _D =250μA V _{GS} =0V	150			V
Gate threshold voltage	V _{GS(th)}	I _D = 250μA V _{DS} =V _{GS}	1.0		2.5	V
Zero gate voltage drain current	I _{DSS}	V _{DS} =150V V _{GS} =0V V _{DS} =120V V _{GS} =0V	T _{ch} =25°C		25	μA
			T _{ch} =125°C		250	
Gate-source leakage current	I _{GSS}	V _{GS} =±20V V _{DS} =0V		10	100	nA
Drain-source on-state resistance	R _{DS(on)}	I _D =11.5A	V _{GS} =4V	65	90	mΩ
			V _{GS} =5V	60	81	
			V _{GS} =10V	54	70	
Forward transconductance	g _{fs}	I _D =11.5A V _{DS} =25V	12	24		S
Input capacitance	C _{iss}	V _{DS} =75V		1900	2850	pF
Output capacitance	C _{oss}	V _{GS} =0V		200	300	
Reverse transfer capacitance	C _{rss}	f=1MHz		17	25.5	ns
Turn-on time t _{on}	td(on)	V _{CC} =48V I _D =11.5A		10	15	
	t _r	V _{GS} =10V		15	23	
Turn-off time t _{off}	td(off)	R _{GS} =10 Ω		85	128	
	t _f			12	18	
Total Gate Charge	Q _G	V _{CC} =48V		46	70	nC
Gate-Source Charge	Q _{GS}	I _D =23A		8	12	
Gate-Drain Charge	Q _{GD}	V _{GS} =10V		12.5	19	
Avalanche capability	I _{AV}	L=228μH T _{ch} =25°C	33			A
Diode forward on-voltage	V _{SD}	I _F =23A V _{GS} =0V T _{ch} =25°C		1.10	1.65	V
Reverse recovery time	t _{rr}	I _F =23A V _{GS} =0V		0.13		μs
Reverse recovery charge	Q _{rr}	-di/dt=100A/μs T _{ch} =25°C		0.6		μC

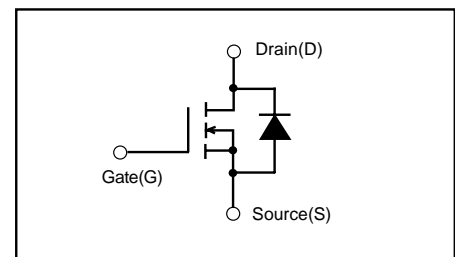
● Thermal characteristics

Item	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Thermal resistance	R _{th(ch-c)}	channel to case			2.359	°CW
	R _{th(ch-a)}	channel to ambient			58.0	°CW

■ Outline Drawings [mm]



■ Equivalent circuit schematic



Characteristics

